


<b>Search Notes</b>  	<b>Application/Control No.</b>  10668929	<b>Applicant(s)/Patent Under Reexamination</b>  YOSHII ET AL.
	<b>Examiner</b>  HOAN C NGUYEN	<b>Art Unit</b>  2871

SEARCHED			
Class	Subclass	Date	Examiner
349	update	4/3/08	CHN
349	113-114	10/16/2008	chn
359	850-866, 868 and 869	10/16/2008	chn

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	4/3/08	CHN
East search in US-PGPUB, USPAT, EPO, JPO, Derwent and IBM_TDB	10/16/2008	chn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	All subclasses above and TEXT search	10/16/2008	chn

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